Notice of References Cited Application/Control No. 10/575,437 Examiner DAVID BANH U.S. PATENT DOCUMENTS Applicant(s)/Patent Under Reexamination BURDINSKI ET AL. Art Unit 2854 Page 1 of 1

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*	Α	US-2003/0047535 A1	03-2003	Schueller et al.	216/41	
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